## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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In Re:

Wenbing Yun et al.

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Application No:

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Assaf, Fayez G.

For:

No.

Short Wavelength Metrology

**Imaging System** 

Customer No.:

29127

Attorney Docket

0002.0004.us

## **AMENDMENT UNDER RULE 312**

## **Commissioner for Patents**

P.O. Box 1450 Alexandria, Virginia 22313-1450

Sir:

In response to the Notice of Allowability mailed June 19, 2007 (Paper No. 20070609), please amend the above-captioned patent application as follows:

-amendments to the claims are reflected in the listing of claims in the Listing of Claims section;

Finally, reconsideration is requested in view of the remarks set forth in the Remarks section.